

33rd SWTest 2024 Conference and EXPO in Carlsbad, CA



Welcome to 33rd SWTest 2024 Conference and EXPO in Carlsbad, CA

Jerry Broz, PhD SWTest General Chair

Welcome to SWTest Conference and EXPO June 3 to 5, 2024

Omni - La Costa, Carlsbad, CA



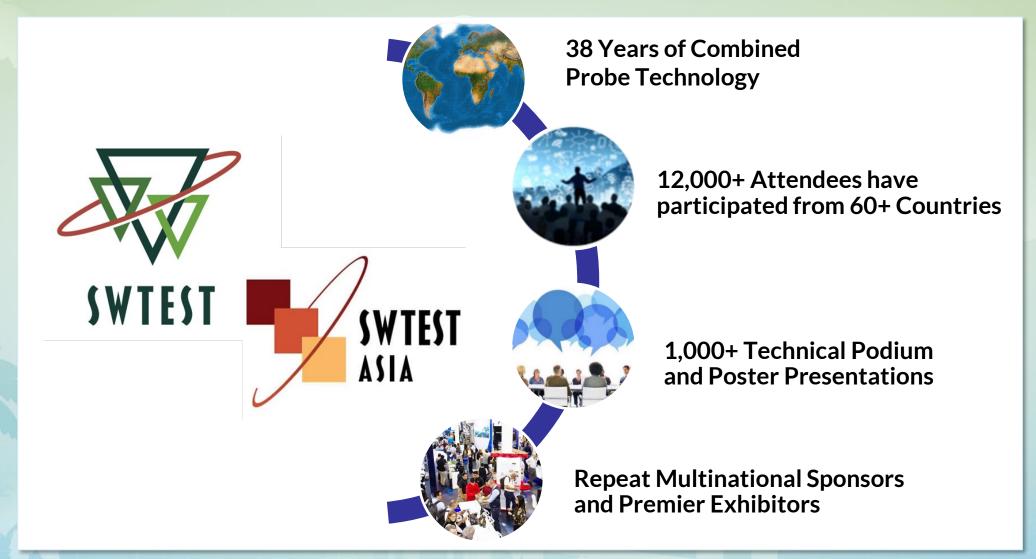
SWTest 2024 eProceedings Download



Password for Monday = blueberry Password for Tuesday = Password for Wednesday =

- Each day of the conference will be available in an e-Version for download in a password protected file.
 - Network (SSID) = Omni Meeting
 - Session and Expo WiFi Password = swtest24
 - Download at = https://www.swtest.org/
- Free WiFi access will be available during the entire conference to allow attendee access to the downloads.
- Daily passwords to the download files will be announced throughout each day, respectively.
- Non-password locked files will be made available in the SWTest Archives after the conference adjourns.

SWTest San Diego and SWTest Asia



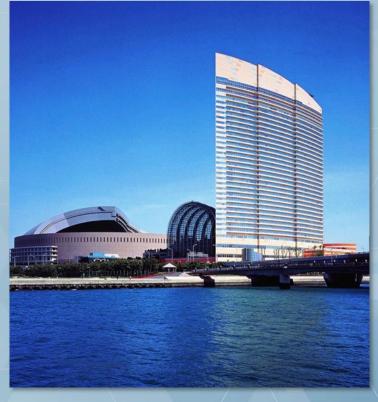
SWTest Asia 2024 Japan

- Schedule: October 24-26, 2024
- Location: Hilton Fukuoka Sea Hawk
- Conference Day 1 (Oct. 24, 2024)
 - Opening and Visionary Keynote
 - Yasuura Hirota, PhD (Vice Director General, National Institute of Information)
 - Podium Sessions
 - Key Supplier Expo & Poster Sessions
 - Platinum Sponsor Tech-Showcase
 - Networking Event in Expo Hall
- Conference Day 2 (Oct. 25, 2024)
 - Opening and Industry Vision Presentations
 - Shinya Akata (GM SONY) and Tetsu Ozawa (GM Socionext)
 - Podium Sessions
 - Key Supplier Expo & Poster Sessions
 - Platinum Sponsor Tech-Showcase
 - Outdoor Networking Event (屋台, Fukuoka Yatai)
- Charity Golf Tournament and Networking Day 3 (Oct. 26, 2024)
 - Benefit Golf Tournament to support student participation.









SWTest Asia 2024 in Fukuoka, Japan



October 24 – 26, 2024 Hilton Fukuoka Sea Hawk Fukuoka, Japan

Abstract Submission Deadline Extended to July 26th

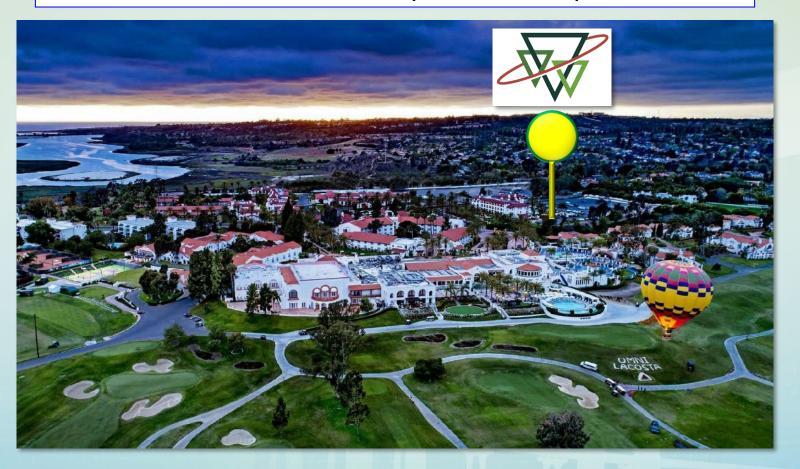


SWTest Asia celebrates its 5th Anniversary in Fukuoka, Japan October 24 - 26, 2024!

5th Annual SWTest Asia | Fukuoka, Japan, October 24-26, 2024

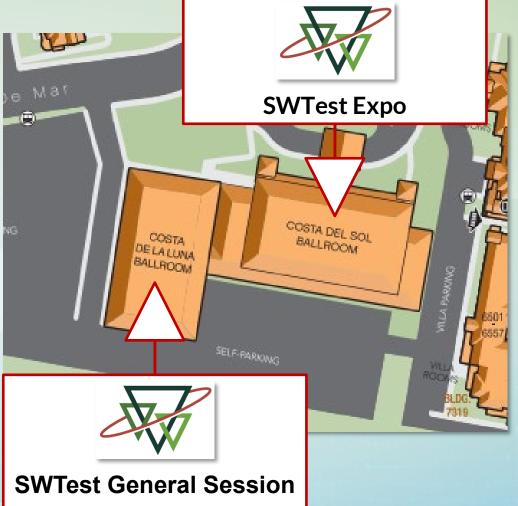
Mark your Calendar for June 2 to 4, 2025 SWTest 2025 Conference and Expo

Omni - La Costa, Carlsbad, CA



SWTest 2024 Property Map





SWTest Organization

SWTest Executive Team

- Jerry Broz, PhD, General Chair and Sr. Member IEEE
- Rey Rincon, Technical Program Chair
- Patrick Mui, Technical Program Co-Chair
- Maddie Harwood, Finance Chair & Conference Mgmt

SWTest is organized, coordinated, and executed through the efforts of your colleagues.

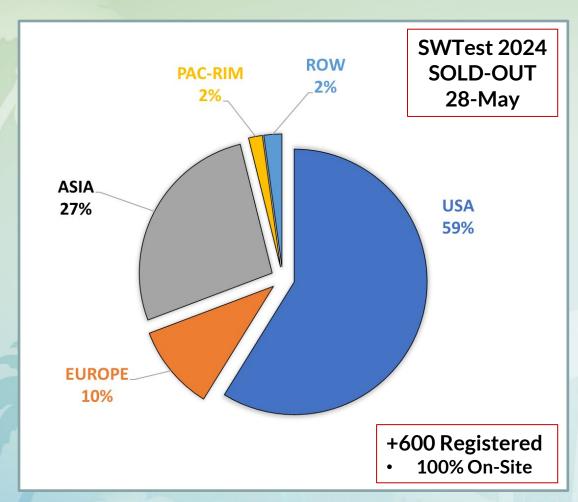
Technical Program Committee

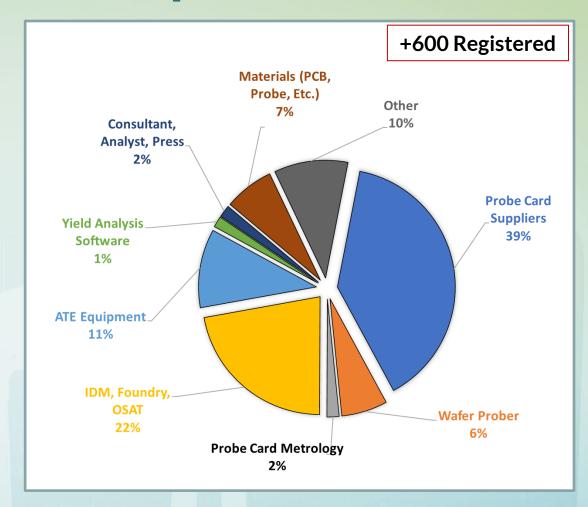
- John Caldwell, MJC Electronics Corp. (US)
- Geert Gouwy, imec (Belgium)
- Clark Liu, Taiwan MJC Co. (Taiwan)
- Muru Meyyappan, Enfabrica (US)
- Patrick Mui, JEM America (US)
- Mark Ojeda, Infineon (US)
- Rey Rincon, PTSL (US)
- Raffaele Vallauri, Technoprobe (Italy)
- Joey Wu, Member-at-Large (Taiwan)

Steering Members

- Davide Appello, Technoprobe (Italy)
- Karen Armendariz, Celadon Systems (US)
- Michael Huebner, PhD, FormFactor, Inc. (Germany)
- Joonyeon (JY) Kim, Samsung Electronics (Korea)
- Amy Leong, AEM (Singapore)
- Alistair Laing, Micron Technology (US)
- Grace Liu, PhD, Intel Corporation (US)
- Karan Marnier, AEM (US)
- Connie Smith, Texas Instruments (US)

SWTest 2024 Participation





Over 65% of Presentations have International Authors!

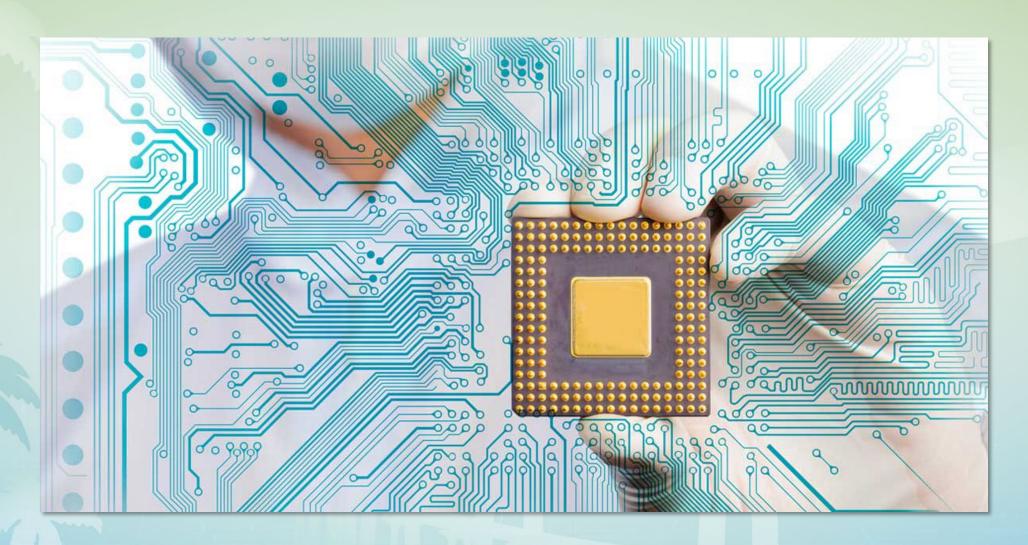
Phishing for SWTest Mailing List and Third-Party Hotel Reservations



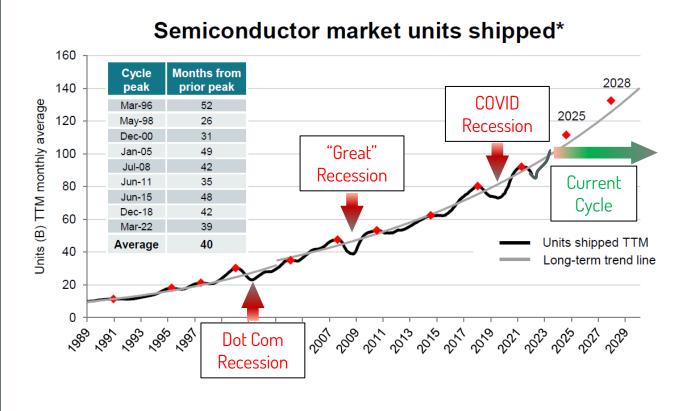
- ALL attendee information provided to SWTest and SWTest Asia is safe, kept confidential, and never sold.
- Attendees must "opt-in" for sharing their contact information through the conference Mobile App
- Attendee details are not made available to anyone without permission.
- SWTest works directly with the hotel and <u>DOES</u>
 <u>NOT</u> use third-party hotel brokers.

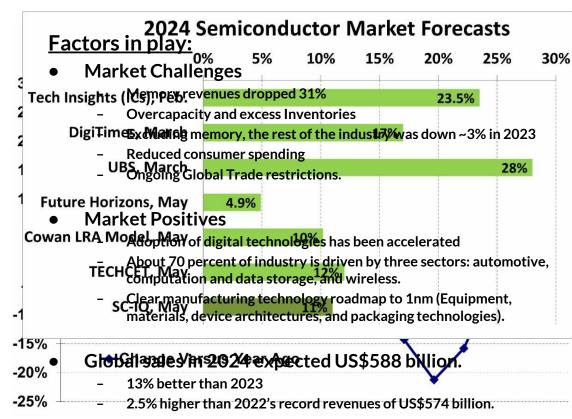
Never have and never will!

Semiconductor Landscape



Semiconductor Is Notoriously Cyclical





Source: Texas Instruments Investor Day - 2024

Insatiable Consumer Appetite

Data Cloud and Al

High-Capacity Storage, and HPC growing from 5 Zettabytes to > 40 Zettabytes

5G and Massive Connectivity

More than 1.1 billion smart-device and high-volume connections

Smart Devices

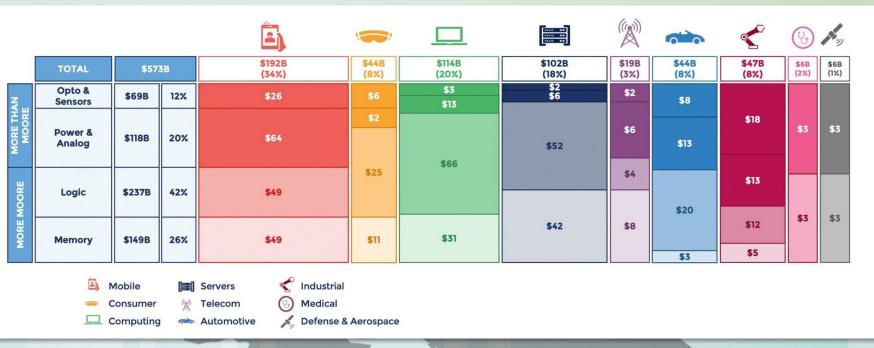
More than 250 million wearables and high-performance devices

Internet of Things

50B connected devices of low-cost devices and massive data volumes

Automotive Electronics

89 million connected cars each generating and processing > 1GB of data per second



Source: Yole Intelligence Industry Report, 2023

Process Everything | Store More Data | Compute Faster

High Costs of Leading-Edge Innovation











\$800B Global Investment



\$205B

- US CHIPS Act \$52B
- Intel \$40B
- TI \$41B
- Micron \$35B
- Wolfspeed \$5B



\$61B

- EU CHIPS Act \$47B
- Infineon \$6B
- Bosch \$3B
- ASML \$0.5B/yr



\$143B+

Objective: 100% domestic self sufficiency by 2030



\$8B

- SONY \$7B
- Gov't \$1B

\$115B

- **TSMC \$100B**
- UMC \$15B

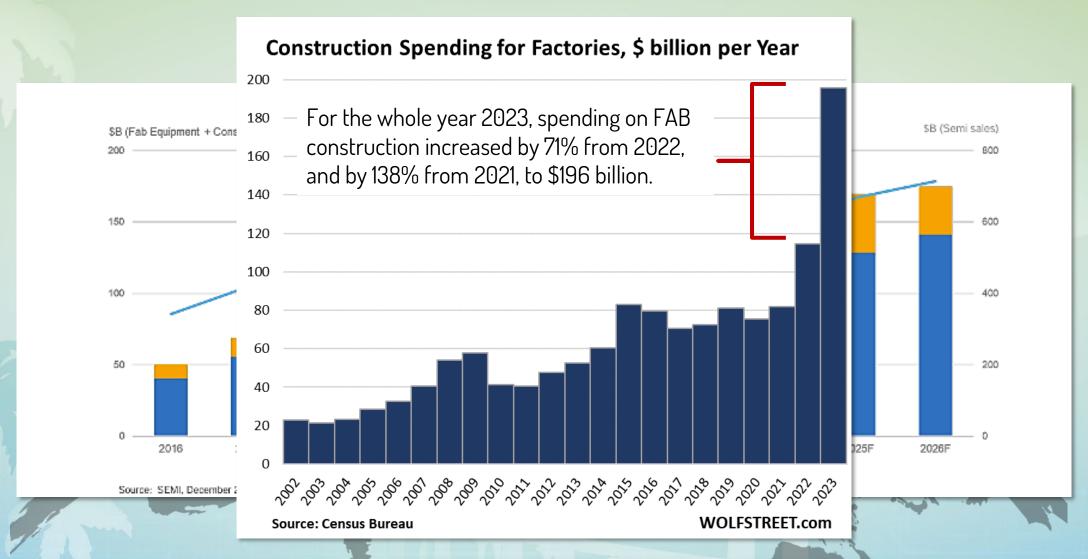


\$241B+

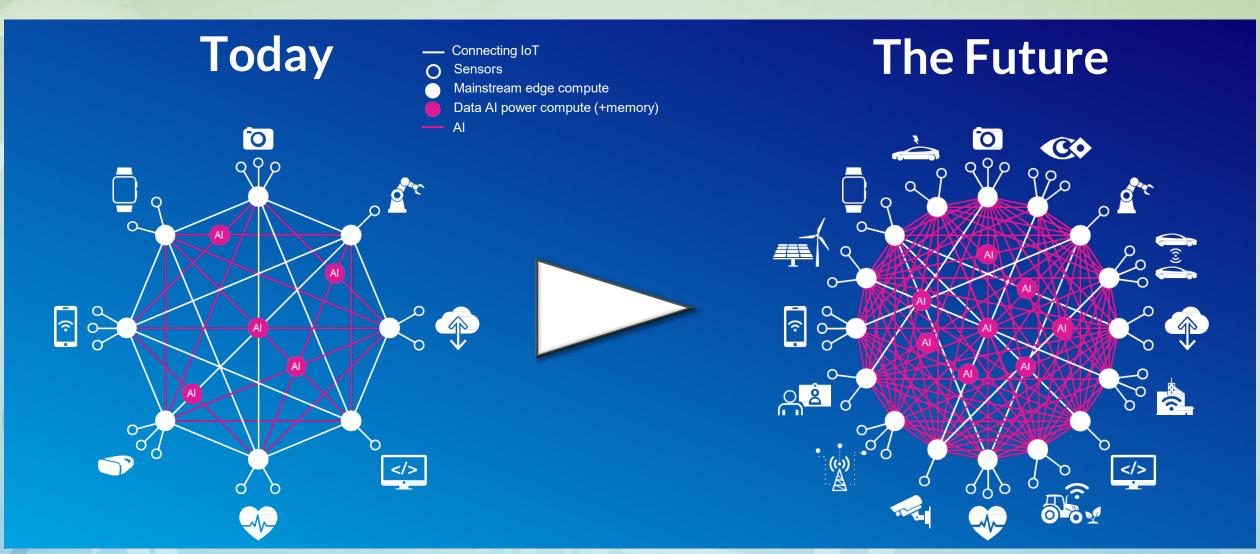
- Samsung \$230B
- SK Hynix \$11B

Source: WSTS, SIA, Yole Intelligence Industry Report, 2023

Global FAB Spending

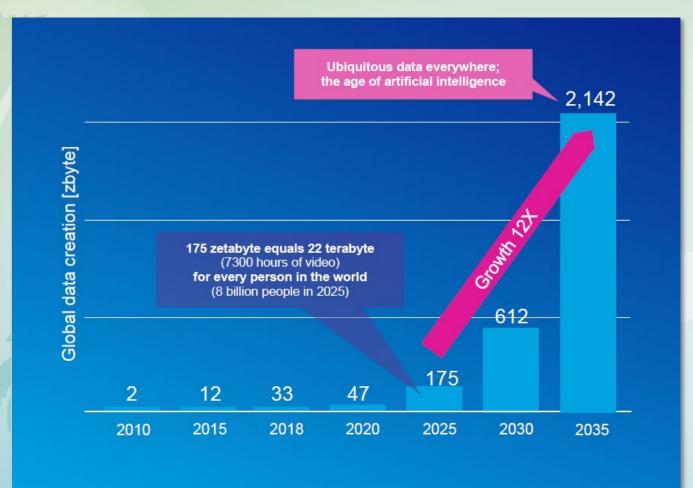


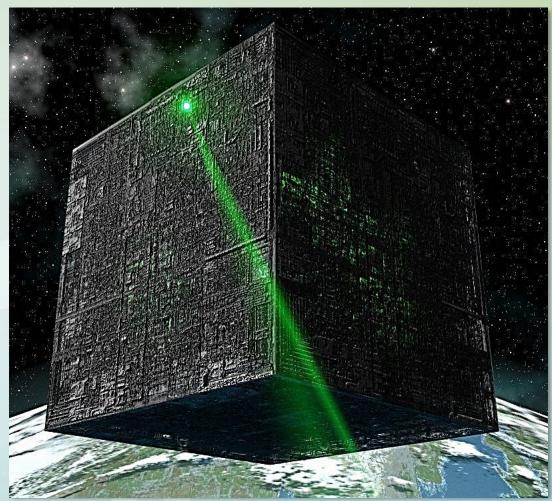
Data Creation Drives Al



ASML Investors Meeting, 2024

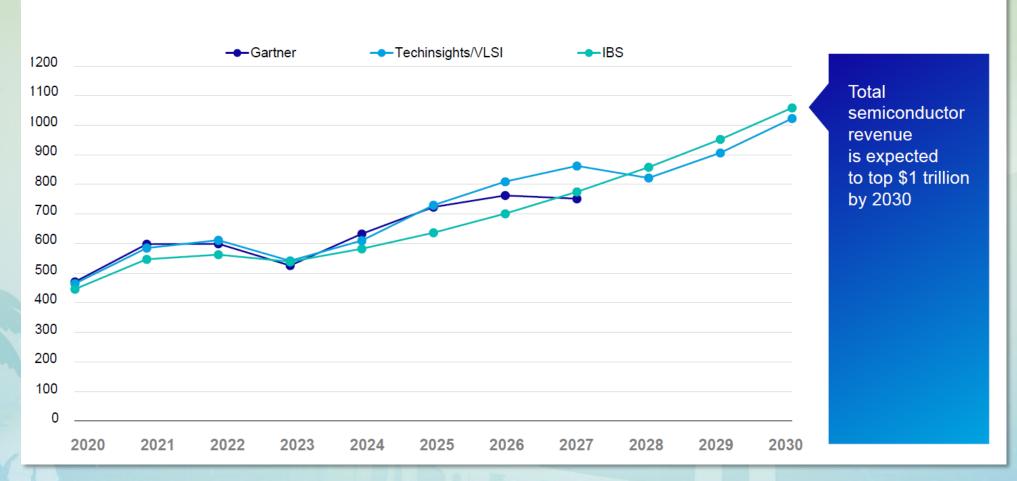
Data Creation That Fuels Al





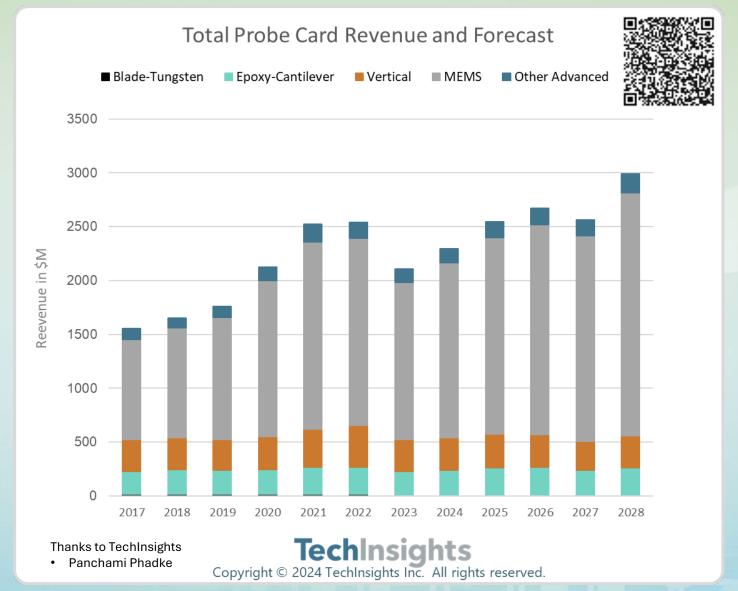
Total Revenue Predictions Towards 2030

Market expectations remain unchanged: around 1 trillion of sales by 2030



J. Broz

Probe Card Market Landscape

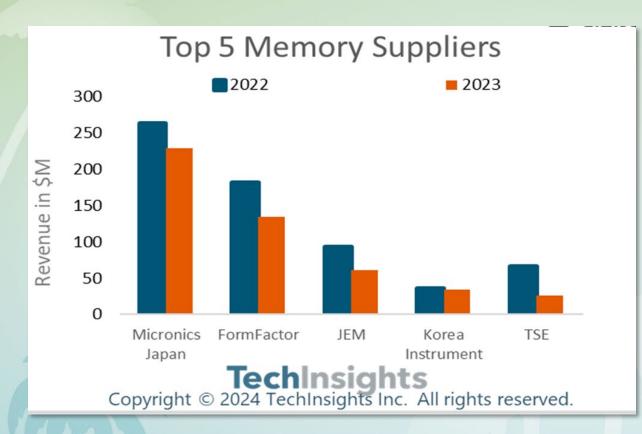


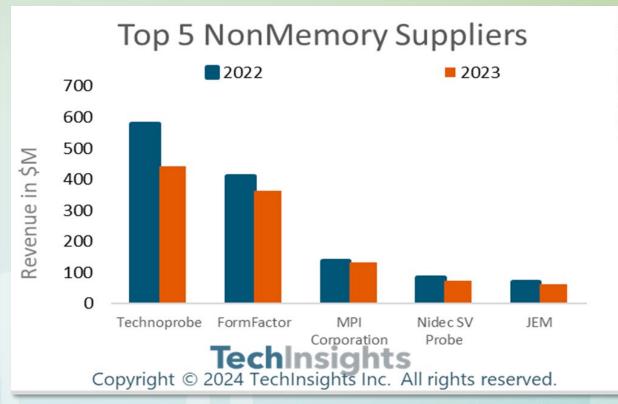
Top Probe Card Vendors of 2023

Semiconductor Probe Cards		Tech Thanks to TechInsights	
Sales, \$M, Calendar Year		• Panchami Phadke	
Rank	Company	Market	% Growth
		2023	YoY
1	FormFactor	497.9	-15.8%
2	Technoprobe	442.5	-23.3%
3	Micronics Japan	259.6	-15.5%
4	MPI Corporation	133.3	-3.7%
5	JEM	116.7	-24.5%
6	Nidec SV Probe	73.2	-13.0%
7	Korea Instrument	65.1	-7.9%
8	Will Technology	46.1	6.2%
9	STAr Technologies	41.1	-19.0%
10	Synergie CAD	40.3	10.8%
1			
Other		393.7	-13.1%
		2400.2	
Probe Card Sales		2109.3	
Annual Growth		-17.0%	

	conductor Probe Cards	Thanks to Yole Group John West	
Sales, \$M, Calendar Year			
Rank	Company	Market	% Growth
		2023	YoY
1	FormFactor	495.0	-16.3%
2	Technoprobe	390.0	-32.4%
3	Micronics Japan	260.0	-15.4%
4	MPI Corporation	135.0	-2.5%
5	JEM	120.0	-22.4%
6	Korea Instrument	70.0	-1.0%
7	STAr Technologies	55.0	8.5%
8	Nidec SVTCL	50.0	-40.6%
9	Will Technology	45.0	-31.6%
10	Max One	40.0	-15.8%
Other		460.0	-0.2%
	Probe Card Sales	2120.0	
			1
Annual Growth		-16.0%	

PC Market Rank by Application









Thanks to TechInsights

Panchami Phadke

Technical Program Overview

- Sunday, June 2
 - William Mann Memorial Benefit Golf Tournament



- Monday, June 3
 - Technical Program with a Visionary Keynote and 4-Technical Sessions / Poster Session
 - SWTest EXPO with 68-Key Suppliers and w/ Meal Reception Stations
 - Meet and Greet with the Speakers at the "Speaker's Corner"
- Tuesday, June 4
 - SWT Crew Update and 3-Technical Sessions / Poster Session
 - SWTest EXPO with 68-Key Suppliers On-site
 - Meet and Greet with the Speakers at the "Speaker's Corner"
 - Tuesday night Social and Networking Event
- Wednesday, June 5
 - Technical Program with 2-Technical Sessions
 - Conference adjourns









Visionary Keynotes for 2024

Known Good Die as a Key Enabler for Advanced Packaging in a Disaggregated World



Joseph PARKS, PhD

VP of Technology Development Intel Corporation

intel

Packaging Trends in the Power Semiconductor Market



Joseph ROYBAL

SVP, Global Backend Operations Wolfspeed, Inc.



SWTest Conference Mobile App





Download mobile app from respective online stores and enter your registered email.

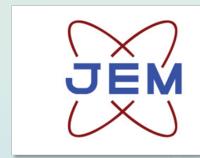
- Up-to-the-minute Event Info
- Connect with the Sponsors and Exhibitors
- Program Schedule in the Agenda
- View Exhibitor and Sponsor Videos
- Read the Literature from the Exhibitors
- Connect with Attendees that have "opted-in"
- Check out the Job Board Postings

Platinum Sponsors



















Gold Sponsors























Silver Sponsors





















Recognition & Awards

- Best Overall Presentation
- Best Data Presentation
- Most "Inspirational" Presentation
- Best Presentation, Tutorial in Nature
- People's Choice Award

 A presentation from SWTest 2024 will be selected for publication in Chip Scale Review



SWTest 2023 Awards

Best Presentation, Tutorial in Nature

High Heat Dissipation: Facing New Challenges with High-Power Testing at the Wafer Level

Lane Huston (Micron Technology-USA)

Most Inspirational Presentation (tie)

MEMS Probe Cards for Advanced High-Volume Inline Process Control Monitoring (PCM) and End-of-Line Wafer-Acceptance Tests (WAT)

Choon-Leong Lou, Yu-Ming Chien, Daniel Lo, Tee Whay Lim, Jee Fong Jong, Eric Sik Kiang Lau (STAr Technologies – Taiwan)

Flying Probe Card Design for Medical and Other Challenging Applications

Luca Fanelli (SPEA S.p.A. – Italy)







SWTest 2023 Awards

Best Data Presentation People's Choice Award

Maximizing CCC in a Probe Card and the March to an Unburnable Probe

David Raschko and Hadi Najar (FormFactor - USA)



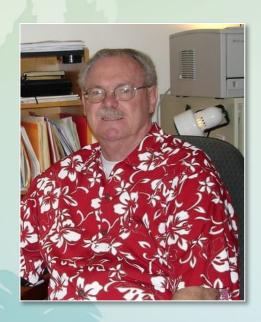
High Speed Probe Card architecture for High End Devices

Xin-Reng Foo and Chee Hoe Lin (AMD – Singapore)
Raffaele Vallauri and Alberto Berizzi (TechnoProbe – Italy)





William R. Mann Student Travel Grant



Bill Mann Founder of SWTest

- Partially funded by the Sponsors and Exhibitors Golf Team registration fees.
- SWTest Conference provides a stipend of up to \$1,000 to cover expenses for travel, hotel accommodations, and student registration.
- Student Grant was Awarded for 2024
 - Dipl.-Ing. Lea Andrea Lumper, *PhD Student at Montanuniversität Leoben (University of Mining Leoben/ Austria)*
 - Laura Mae Welcomer, *Undergraduate Student at Pennsylvania State University* (University Park), State College, PA

Want to Learn More?

 Chip Scale Review https://chipscalereview.com/



TechInsights https://www.techinsights.com/



 IEEE European Test Symposium (ETS) https://www.ieee-ets.org/



 Yole Group http://www.yole.fr/



TestConX
 Formerly BiTS Burn In & Test Strategies
 https://www.testconx.org/



 IS-Test Conference http://www.is-test.com



SEMI - Test Vision Symposium
 https://www.semi.org/en/connect/events/test-vision-symposium



Semiconductor Review https://www.semiconductorreview.com/



Monday, June 3, 2024

8:00 to 8:15 Opening Remarks for SWTest 2024

Jerry Broz, PhD (SWTest General Chair)

8:15 to 9:30 - Visionary Keynote

Known Good Die as a Key Enabler for Advanced Packaging in a Disaggregated World

Joseph PARKS, PhD
VP of Technology Development
Intel Corporation



